

2. Submissions via the U.S. Postal Service: Foreign-Trade Zones Board, U.S. Department of Commerce, FCB-Suite 4100W, 1401 Constitution Avenue, NW., Washington, DC 20230.

The closing period for their receipt is November 19, 2002. Rebuttal comments in response to material submitted during the foregoing period may be submitted during the subsequent 15-day period (to December 4, 2002).

A copy of the application and accompanying exhibits will be available during this time for public inspection at address Number 1 listed above, and at the U.S. Department of Commerce, Export Assistance Center, 500 Dallas, Suite 1160, Houston, TX 77002. The Export Assistance Center may be relocated later this year, and we suggest that you call ahead for an appointment (713/718-3062).

Dated: September 13, 2002.

Dennis Puccinelli,

Executive Secretary.

[FR Doc. 02-24008 Filed 9-19-02; 8:45 am]

BILLING CODE 3510-DS-P

capability of a 6-inch cube or better. A domestic manufacturer of similar of equipment advised September 12, 2002 that (1) these capabilities are pertinent to the applicant's intended purpose and (2) it knows of no domestic instrument or apparatus of equivalent scientific value to the foreign instrument for the applicant's intended use.

We know of no other instrument or apparatus of equivalent scientific value to the foreign instrument which is being manufactured in the United States.

Gerald A. Zerdy,

Program Manager, Statutory Import Programs Staff.

[FR Doc. 02-24005 Filed 9-19-02; 8:45 am]

BILLING CODE 3510-DS-P

DEPARTMENT OF COMMERCE

International Trade Administration

University of Minnesota; Notice of Decision on Application for Duty-Free Entry of Scientific Instrument

This decision is made pursuant to section 6(c) of the Educational, Scientific, and Cultural Materials Importation Act of 1966 (Pub. L. 89-651, 80 Stat. 897; 15 CFR part 301). Related records can be viewed between 8:30 a.m. and 5 p.m. in Suite 4100W, U.S. Department of Commerce, Franklin Court Building, 1099 14th Street, NW., Washington, DC.

Docket Number: 02-028. Applicant: University of Minnesota, Minneapolis, MN 55455. Instrument: High-Pressure/High-Temperature Materials Testing Apparatus with Torsion Module. Manufacturer: Australian Scientific Instruments Pty Ltd, Australia. Intended Use: See notice at 67 FR 47524, July 19, 2002.

Comments: None received. Decision: Approved. No instrument of equivalent scientific value to the foreign instrument, for such purposes as it is intended to be used, is being manufactured in the United States.

Reasons: The foreign instrument provides a unique combination of high pressure (700 MPa), high temperature (1650° K) and both compressive and torsional deformation with high stress and displacement resolution for geophysical study of rocks. A university research laboratory advised September 10, 2002 that (1) this capability is pertinent to the applicant's intended purpose and (2) it knows of no domestic instrument or apparatus of equivalent scientific value to the foreign instrument for the applicant's intended use.

We know of no other instrument or apparatus of equivalent scientific value to the foreign instrument which is being manufactured in the United States.

Gerald A. Zerdy,

Program Manager, Statutory Import Programs Staff.

[FR Doc. 02-24006 Filed 9-19-02; 8:45 am]

BILLING CODE 3510-DS-P

DEPARTMENT OF COMMERCE

International Trade Administration

Massachusetts Institute of Technology; Notice of Decision on Application for Duty-Free Entry of Scientific Instrument

This decision is made pursuant to section 6(c) of the Educational, Scientific, and Cultural Materials Importation Act of 1966 (Pub. L. 89-651, 80 Stat. 897; 15 CFR part 301). Related records can be viewed between 8:30 a.m. and 5 p.m. in Suite 4100W, U.S. Department of Commerce, Franklin Court Building, 1099 14th Street, NW., Washington, DC.

Docket Number: 02-024. Applicant: Massachusetts Institute of Technology, Cambridge, MA 02139-4307. Instrument: Universal 5 Axis High Speed Machining Center, Model UCP 600. Manufacturer: Mikron, Switzerland. Intended Use: See notice at 67 FR 45481, July 9, 2002.

Comments: None received. Decision: Approved. No instrument of equivalent scientific value to the foreign instrument, for such purposes as it is intended to be used, is being manufactured in the United States.

Reasons: The foreign instrument provides: (1) Simultaneous 5-axis shaping with demonstrated software for turbine blades, (2) very high positioning accuracy (<0.0002 inch), (3) optical feedback positioning technology such as glass scales and (4) 5-axis shaping

DEPARTMENT OF COMMERCE

International Trade Administration

Thomas Jefferson University; Notice of Decision on Application for Duty-Free Entry of Electron Microscope

This is a decision pursuant to section 6(c) of the Educational, Scientific, and Cultural Materials Importation Act of 1966 (Pub. L. 89-651, 80 Stat. 897; 15 CFR part 301). Related records can be viewed between 8:30 a.m. and 5 p.m. in Suite 4100W, U.S. Department of Commerce, Franklin Court Building, 1099 14th Street, NW., Washington, DC.

Docket Number: 02-032. Applicant: Thomas Jefferson University, Philadelphia, PA 19107-5587. Instrument: Electron Microscope, Model Morgagni 268 Film version. Manufacturer: FEI Company, The Netherlands. Intended Use: See notice at 67 FR 52944, August 14, 2002. Order Date: June 4, 2002.

Comments: None received. Decision: Approved. No instrument of equivalent scientific value to the foreign instrument, for such purposes as the instrument is intended to be used, was being manufactured in the United States at the time the instrument was ordered. Reasons: The foreign instrument is a conventional transmission electron microscope (CTEM) and is intended for research or scientific educational uses requiring a CTEM. We know of no CTEM, or any other instrument suited to these purposes, which was being manufactured in the United States at the time of order of the instrument.

Gerald A. Zerdy,

Program Manager, Statutory Import Programs Staff.

[FR Doc. 02-24007 Filed 9-19-02; 8:45 am]

BILLING CODE 3510-DS-P